

## Hi-Rel 60 V, 0.6 A PNP transistor

Datasheet - production data

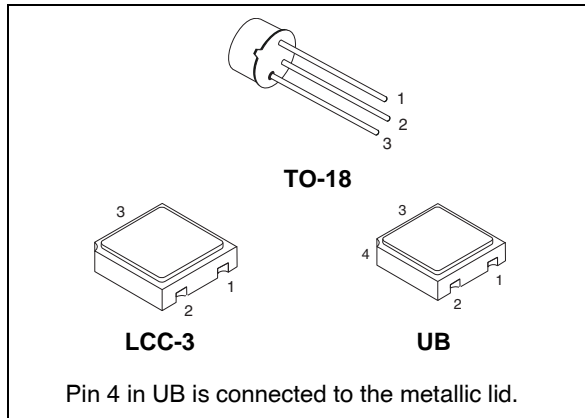
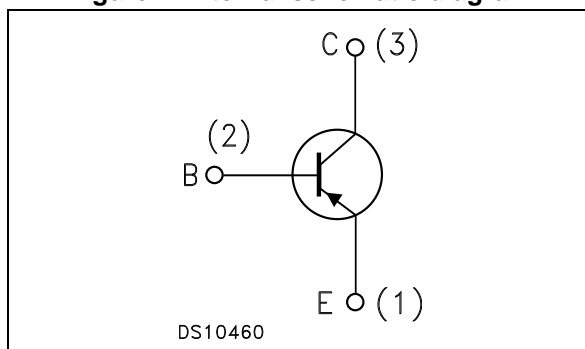


Figure 1. Internal schematic diagram



### Features

Parameter	Value
$BV_{CEO}$	60 V
$I_C$ (max)	0.6 A
$H_{FE}$ at 10 V - 150 mA	> 100

- Hermetic packages
- ESCC and JANS qualified
- European preferred part list EPPL

### Description

The 2N2907AHR is a silicon planar PNP transistor specifically designed and housed in hermetic packages for aerospace and Hi-Rel applications. It is available in the JAN qualification system (MIL-PRF19500 compliance) and in the ESCC qualification system (ESCC 5000 compliance). In case of discrepancies between this datasheet and the relevant agency specification, the latter takes precedence.

Table 1. Device summary

Device	Qualification system	Agency specification	Package	Radiation level	EPPL
JANS2N2907AUBx	JANS	MIL-PRF-19500/291	UB	-	-
2N2907ARUBx	ESCC	5202/001	UB	100 krad ESCC	Target
2N2907AUB0xSW35	ESCC	5202/001	UB	100 krad SW	-
2N2907AUB0x	ESCC	5202/001	UB	-	Target
SOC2907ARHRx	ESCC	5202/001	LCC-3	100 krad ESCC	Yes
SOC2907ASW35	ESCC	5202/001	LCC-3	100 krad SW	-
SOC2907AHRB	ESCC	5202/001	LCC-3	-	Yes
2N2907ARHRx	ESCC	5202/001	TO-18	100 krad ESCC	-
2N2907ASW35	ESCC	5202/001	TO-18	100 krad SW	-
2N2907AHR	ESCC	5202/001	TO-18	-	-

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# Contents

<b>1</b>	<b>Electrical ratings</b> .....	<b>3</b>
<b>2</b>	<b>Electrical characteristics</b> .....	<b>4</b>
2.1	JANS electrical characteristics .....	4
2.2	ESCC electrical characteristics .....	5
2.3	Electrical characteristics (curves) .....	6
2.4	Test circuits .....	7
<b>3</b>	<b>Radiation hardness assurance</b> .....	<b>9</b>
<b>4</b>	<b>Package mechanical data</b> .....	<b>13</b>
<b>5</b>	<b>Order codes</b> .....	<b>17</b>
<b>6</b>	<b>Shipping details</b> .....	<b>19</b>
6.1	Date code .....	19
6.2	Documentation .....	19
<b>7</b>	<b>Revision history</b> .....	<b>20</b>

# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-base voltage ( $I_E = 0$ )	-60	V
$V_{CEO}$	Collector-emitter voltage ( $I_B = 0$ )	-60	V
$V_{EBO}$	Emitter-base voltage ( $I_C = 0$ )	-5	V
$I_C$	Collector current for TO-18	-0.6	A
	for LCC-3 and UB	-0.5	A
$P_{TOT}$	Total dissipation at $T_{amb} \leq 25\text{ °C}$ ESCC: TO-18	0.4	W
	LCC-3 and UB	0.4	
	LCC-3 and UB <sup>(1)</sup>	0.73	
	JANS: UB	0.5	
	Total dissipation at $T_{case} \leq 25\text{ °C}$ ESCC: TO-18	1.8	
$T_{stg}$	Total dissipation at $T_{sp(IS)} = 25\text{ °C}$ JANS: UB	1	
	Storage temperature	-65 to 200	°C
$T_J$	Max. operating junction temperature	200	°C

1. When mounted on a 15 x 15 x 0.6 mm ceramic substrate.

**Table 3. Thermal data**

Symbol	Parameter	LCC-3 UB	TO-18	Unit
$R_{thJC}$	Thermal resistance junction-case (max) for JANS	-	-	°C/W
	Thermal resistance junction-case (max) for ESCC	-	97	
$R_{thJSP(IS)}$	Thermal resistance junction-solder pad (infinite sink) (max) for JANS	90	-	
	Thermal resistance junction-solder pad (infinite sink) (max) for ESCC	-	-	
$R_{thJA}$	Thermal resistance junction-ambient (max) for JANS	325	-	
	Thermal resistance junction-ambient (max) for ESCC	437 240 <sup>(1)</sup>	437	

1. When mounted on a 15 x 15 x 0.6 mm ceramic substrate.

## 2 Electrical characteristics<sup>(a)</sup>

JANS and ESCC version of the products are assembled and tested in compliance with the agency specification it is qualified in. The electrical characteristics of each version are provided in dedicated tables.

T<sub>case</sub> = 25 °C unless otherwise specified.

### 2.1 JANS electrical characteristics

Table 4. JANS electrical characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I <sub>CBO</sub>	Collector cut-off current (I <sub>E</sub> = 0)	V <sub>CB</sub> = 60 V		-	10	μA
		V <sub>CB</sub> = 50 V			10	nA
		V <sub>CB</sub> = 50 V, T <sub>amb</sub> = 150 °C			10	μA
I <sub>CES</sub>	Collector cut-off current (I <sub>E</sub> = 0)	V <sub>CE</sub> = 50 V		-	50	nA
I <sub>EBO</sub>	Emitter cut-off current (I <sub>C</sub> = 0)	V <sub>EB</sub> = 5 V		-	10	μA
		V <sub>EB</sub> = 4 V			50	nA
V <sub>(BR)CEO</sub> <sup>(1)</sup>	Collector-emitter breakdown voltage (I <sub>B</sub> = 0)	I <sub>C</sub> = 10 mA	60	-		V
V <sub>CE(sat)</sub> <sup>(1)</sup>	Collector-emitter saturation voltage	I <sub>C</sub> = 150 mA, I <sub>B</sub> = 15 mA		-	0.4	V
		I <sub>C</sub> = 500 mA, I <sub>B</sub> = 50 mA			1.6	V
V <sub>BE(sat)</sub> <sup>(1)</sup>	Base-emitter saturation voltage	I <sub>C</sub> = 150 mA, I <sub>B</sub> = 15 mA	0.6		1.3	V
		I <sub>C</sub> = 500 mA, I <sub>B</sub> = 50 mA			2.6	V
h <sub>FE</sub> <sup>(1)</sup>	DC current gain	I <sub>C</sub> = 0.1 mA, V <sub>CE</sub> = 10 V	75	-		
		I <sub>C</sub> = 1 mA, V <sub>CE</sub> = 10 V	100		450	
		I <sub>C</sub> = 10 mA, V <sub>CE</sub> = 10 V	100			
		I <sub>C</sub> = 150 mA, V <sub>CE</sub> = 10 V	100		300	
		I <sub>C</sub> = 500 mA, V <sub>CE</sub> = 10 V	50			
		I <sub>C</sub> = 10 mA, V <sub>CE</sub> = 10 V T <sub>amb</sub> = -55 °C	50			
h <sub>fe</sub>	Small signal current gain	V <sub>CE</sub> = 20 V I <sub>C</sub> = 20 mA f = 100 MHz	2	-		
		V <sub>CE</sub> = 10 V, I <sub>C</sub> = 1 mA f = 1 kHz	100			

a. For PNP type, voltage and current values are negative.

Table 4. JANS electrical characteristics (continued)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{obo}$	Output capacitance ( $I_E = 0$ )	$V_{CB} = 10\text{ V}$ $100\text{ kHz} \leq f \leq 1\text{ MHz}$		-	8	pF
$C_{ibo}$	Output capacitance ( $I_E = 0$ )	$V_{EB} = 2\text{ V}$ $100\text{ kHz} \leq f \leq 1\text{ MHz}$		-	30	pF
$t_{on}$	Turn-on time	$V_{CC} = 30\text{ V}$ , $I_C = 150\text{ mA}$ $I_{B1} = 15\text{ mA}$		-	45	ns
$t_{off}$	Turn-off time	$V_{CC} = 30\text{ V}$ , $I_C = 150\text{ mA}$ $I_{B1} = -I_{B2} = 15\text{ mA}$		-	300	ns

1. Pulsed duration = 300  $\mu\text{s}$ , duty cycle  $\leq 2\%$

## 2.2 ESCC electrical characteristics

Table 5. ESCC electrical characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{CBO}$	Collector cut-off current ( $I_E = 0$ )	$V_{CB} = 50\text{ V}$ , $V_{CB} = 50\text{ V}$ , $T_{amb} = 150\text{ }^\circ\text{C}$		-	10 10	nA $\mu\text{A}$
$V_{(BR)CBO}$	Collector-base breakdown voltage ( $I_E = 0$ )	$I_C = 10\text{ }\mu\text{A}$	60	-		V
$V_{(BR)CEO}^{(1)}$	Collector-emitter breakdown voltage ( $I_B = 0$ )	$I_C = 10\text{ mA}$	60	-		V
$V_{(BR)EBO}$	Emitter-base breakdown voltage ( $I_C = 0$ )	$I_E = 10\text{ }\mu\text{A}$	5	-		V
$V_{CE(sat)}^{(1)}$	Collector-emitter saturation voltage	$I_C = 150\text{ mA}$ , $I_B = 15\text{ mA}$		-	0.4	V
$V_{BE(sat)}^{(1)}$	Base-emitter saturation voltage	$I_C = 150\text{ mA}$ , $I_B = 15\text{ mA}$		0.87	1.3	V
$h_{FE}^{(1)}$	DC current gain	$I_C = 0.1\text{ mA}$ , $V_{CE} = 10\text{ V}$	75	-		
		$I_C = 10\text{ mA}$ , $V_{CE} = 10\text{ V}$	100			
		$I_C = 150\text{ mA}$ , $V_{CE} = 10\text{ V}$	100		300	
		$I_C = 500\text{ mA}$ , $V_{CE} = 10\text{ V}$	50			
$h_{fe}$	Small signal current gain	$V_{CE} = 20\text{ V}$ , $I_C = 20\text{ mA}$ $f = 100\text{ MHz}$	2	-		
$C_{obo}$	Output capacitance ( $I_E = 0$ )	$V_{CB} = 10\text{ V}$ $100\text{ kHz} \leq f \leq 1\text{ MHz}$		-	8	pF

Table 5. ESCC electrical characteristics (continued)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{on}$	Turn-on time	$V_{CC} = 30\text{ V}$ , $I_C = 150\text{ mA}$ $I_{B1} = 15\text{ mA}$		-	45	ns
$t_{off}$	Turn-off time	$V_{CC} = 30\text{ V}$ , $I_C = 150\text{ mA}$ $I_{B1} = -I_{B2} = 15\text{ mA}$		-	300	ns

1. Pulsed duration = 300  $\mu\text{s}$ , duty cycle  $\leq 2\%$

### 2.3 Electrical characteristics (curves)

Figure 2. DC current gain ( $V_{CE} = 1\text{ V}$ )

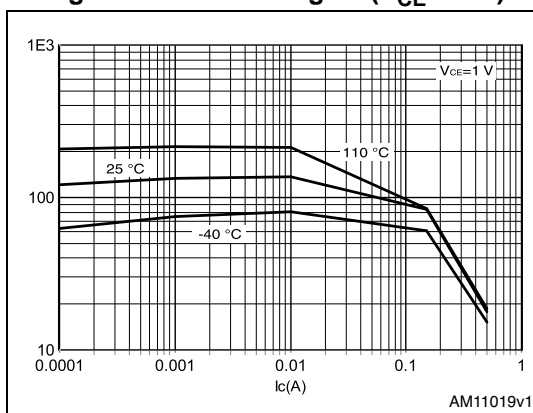


Figure 3. DC current gain ( $V_{CE} = 10\text{ V}$ )

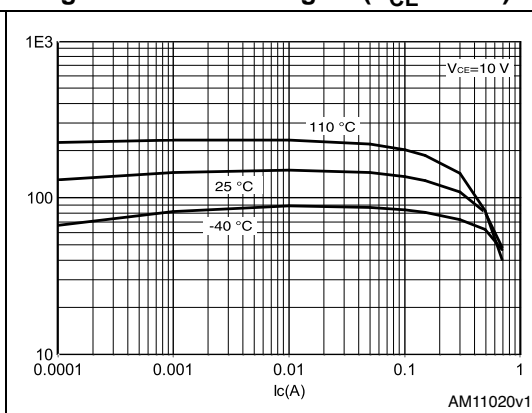


Figure 4. Collector emitter saturation voltage

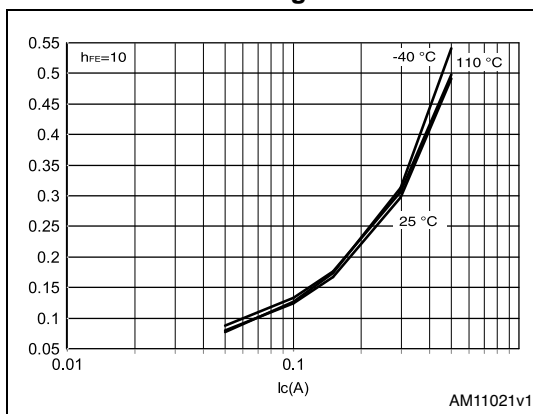
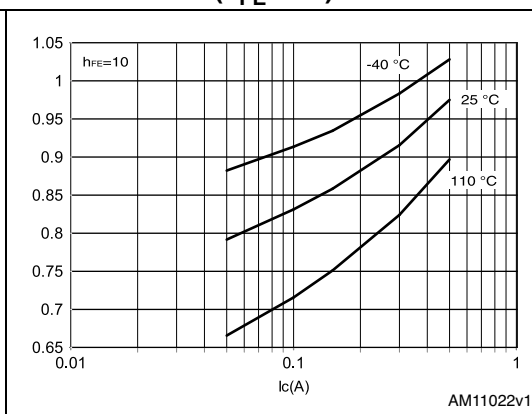


Figure 5. Base emitter saturation voltage ( $h_{FE} = 10$ )



## 2.4 Test circuits

Figure 6. JANS saturated turn-on switching time test circuit

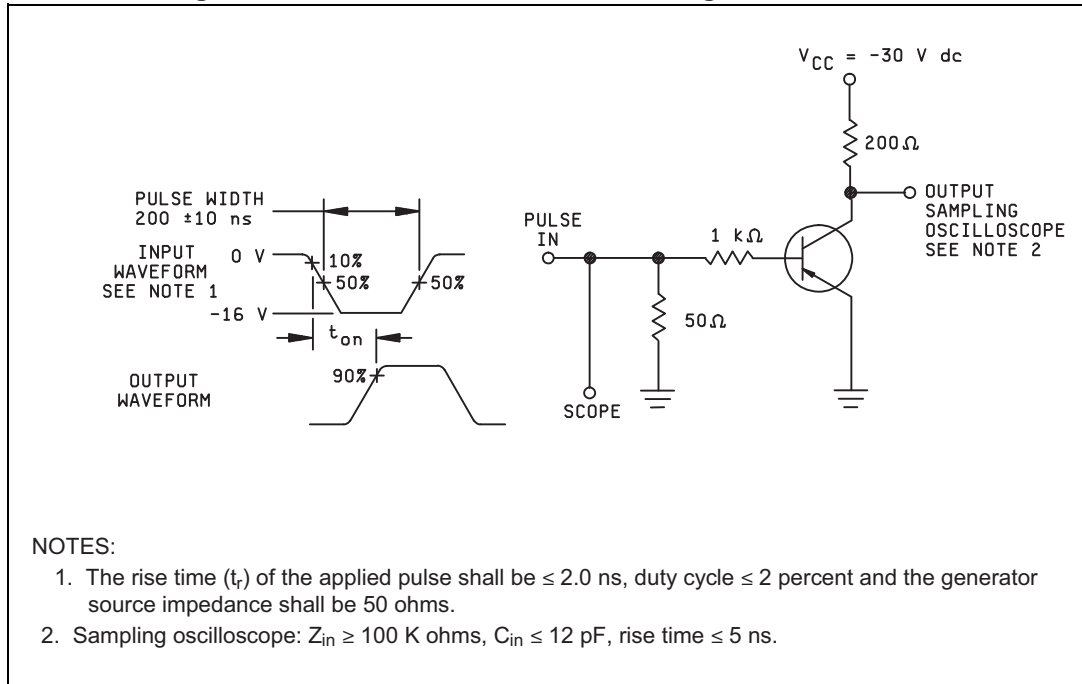


Figure 7. JANS saturated turn-off switching time test circuit

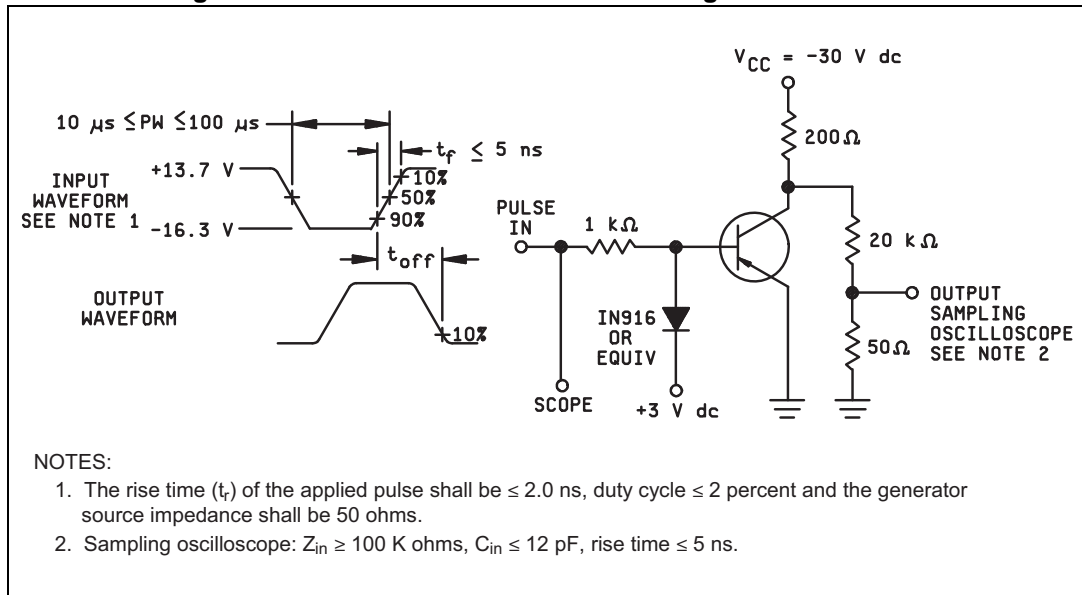
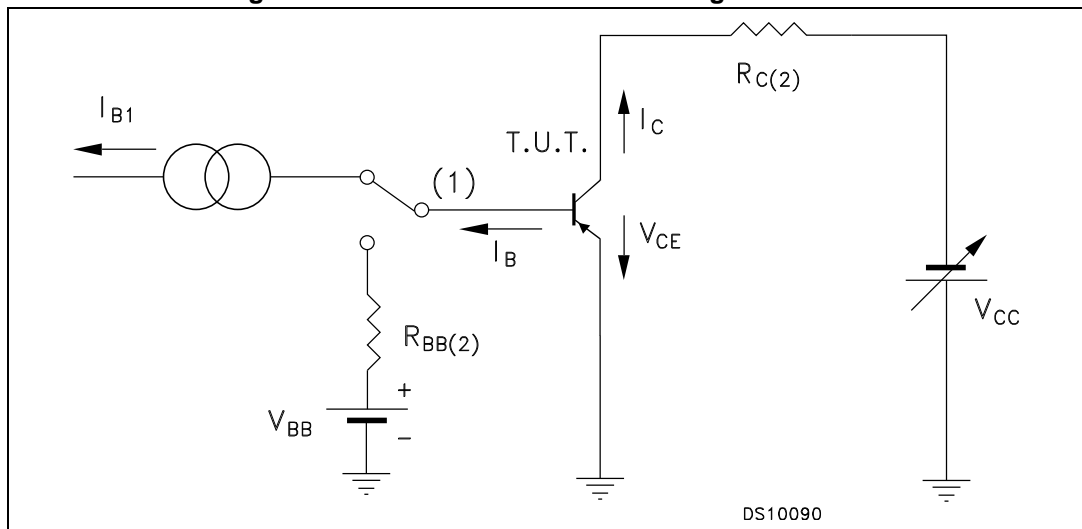


Figure 8. ESCC resistive load switching test circuit



1. Fast electronic switch
2. Non-inductive resistor



### 3 Radiation hardness assurance<sup>(b)</sup>

The products guaranteed in radiation within the JANS system fully comply with the MIL-PRF-19500/291 specification.

The products guaranteed in radiation within the ESCC system fully comply with the ESCC 5202/001 and ESCC 22900 specifications.

#### JANS radiation assurance

ST JANS parts guaranteed at 100 krad (Si), tested, in full compliancy with the MIL-PRF-19500 specification, specifically the Group D, subgroup 2 inspection, between 50 and 300 rad/s. A brief summary is provided below:

- All test are performed in accordance to MIL-PRF-19500 and test method 1019 of MIL-STD-750 for total Ionizing dose.

Each wafer of each lot is tested. The table below provides for each monitored parameters of the test conditions and the acceptance criteria

**Table 6. MIL-PRF-19500 (test method 1019) post radiation electrical characteristics**

Symbol	Parameter	Test conditions	Value		Unit
			Min.	Max.	
I <sub>CBO</sub>	Collector to base cutoff current	V <sub>CB</sub> = 60		20	μA
		V <sub>CB</sub> = 50 V		20	nA
I <sub>EBO</sub>	Emitter to base cutoff current	V <sub>EB</sub> = 5 V		20	μA
		V <sub>EB</sub> = 4 V		100	nA
V <sub>(BR)CEO</sub>	Breakdown voltage, collector to emitter	I <sub>C</sub> = 10 mA	60		V
I <sub>CES</sub>	Collector to emitter cutoff current	V <sub>CE</sub> = 50 V		100	nA
h <sub>FE</sub>	Forward-current transfer ratio	V <sub>CE</sub> = 10 V; I <sub>C</sub> = 0.1 mA	[37.5] <sup>(1)</sup>		
		V <sub>CE</sub> = 10 V; I <sub>C</sub> = 1.0 mA	[50] <sup>(1)</sup>	400	
		V <sub>CE</sub> = 10 V; I <sub>C</sub> = 10 mA	[50] <sup>(1)</sup>		
		V <sub>CE</sub> = 10 V; I <sub>C</sub> = 150 mA	[50] <sup>(1)</sup>	300	
		V <sub>CE</sub> = 10 V; I <sub>C</sub> = 500 mA	[25] <sup>(1)</sup>		
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	I <sub>C</sub> = 150 mA; I <sub>B</sub> = 15 mA		0.46	V
		I <sub>C</sub> = 500 mA; I <sub>B</sub> = 50 mA		1.84	
V <sub>BE(sat)</sub>	Base-emitter saturation voltage	I <sub>C</sub> = 150 mA; I <sub>B</sub> = 15 mA	0.6	1.5	V
		I <sub>C</sub> = 500 mA; I <sub>B</sub> = 50 mA		3	

1. See method 1019 of MIL-STD-750 for how to determine [h<sub>FE</sub>] by first calculating the delta (1/h<sub>FE</sub>) from the pre- and Post-radiation h<sub>FE</sub>. Notice the [h<sub>FE</sub>] is not the same as h<sub>FE</sub> and cannot be measured directly. The [h<sub>FE</sub>] value can never exceed the pre-radiation minimum h<sub>FE</sub> that it is based upon.

b. For PNP type, voltage and current values are negative.

### ESCC radiation assurance

Each product lot is tested according to the ESCC basic specification 22900, with a minimum of 11 samples per diffusion lot and 5 samples per wafer, one sample being kept as unirradiated sample, all of them being fully compliant with the applicable ESCC generic and/or detailed specification.

ST goes beyond the ESCC specification by performing the following procedure:

- Test of 11 pieces by wafer, 5 biased at least 80% of  $V_{(BR)CEO}$ , 5 unbiased and 1 kept for reference
- Irradiation at 0.1 rad (Si)/s
- Acceptance criteria of each individual wafer if as 100 krad guaranteed if all 10 samples comply with the post radiation electrical characteristics provided in [Table 8](#).

Delivery together with the parts of the radiation verification test (RVT) report of the particular wafer used to manufacture the products. This RVT includes the value of each parameter at 30, 50, 70 and 100 krad (Si) and after 24 hour annealing at room temperature and after an additional 168 hour annealing at 100°C.

**Table 7. Radiation summary**

Radiation test	100 krad "SW"	100 krad ESCC
Wafer test	each	each
Part tested	5 biased	5 biased + 5 unbiased
Dose rate	0.1 rad/s	0.1 rad/s
Acceptance	Fixed values <sup>(1)</sup>	MIL-STD-750 method 1019
Displacement damage	Optional	Optional
Agency part number (ex)	5202/001/04 <sup>(2)</sup>	5202/001/04R <sup>(2)</sup>
ST part number (ex)	SOC2N2907ASW35 <sup>(1)</sup>	SOC2N2907ARHRG
Documents	CoC + RVT	CoC + RVT

1. Part numbers with suffix "SW" have same pre and post irradiation electrical characteristics.  
Part number with suffix "SW35" have specific post irradiation electrical characteristics.
2. Example of the 2N2907A in LCC-3 Gold finish.

Table 8. ESCC 5202/001R post radiation electrical characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{CBO}$	Collector cut-off current ( $I_E = 0$ )	$V_{CB} = 50 \text{ V}$		-	10	nA
$I_{EBO}$	Emitter cut-off current ( $I_C = 0$ )	$V_{EB} = 3 \text{ V}$		-	10	nA
$V_{(BR)CBO}$	Collector-base breakdown voltage ( $I_E = 0$ )	$I_C = 10 \mu\text{A}$	60	-		V
$V_{(BR)CEO}^{(1)}$	Collector-emitter breakdown voltage ( $I_B = 0$ )	$I_C = 10 \text{ mA}$	60	-		V V
$V_{(BR)EBO}$	Emitter-base breakdown voltage ( $I_C = 0$ )	$I_E = 10 \mu\text{A}$	5	-		V
$V_{CE(sat)}^{(1)}$	Collector-emitter saturation voltage	$I_C = 150 \text{ mA}$ $I_B = 15 \text{ mA}$		-	0.4	V
$V_{BE(sat)}^{(1)}$	Base-emitter saturation voltage	$I_C = 150 \text{ mA}$ $I_B = 15 \text{ mA}$			1.3	V
$[h_{FE}]^{(1)}$	Post irradiation gain calculation <sup>(2)</sup>	$I_C = 0.1 \text{ mA}$ $V_{CE} = 10 \text{ V}$ $I_C = 10 \text{ mA}$ $V_{CE} = 10 \text{ V}$ $I_C = 150 \text{ mA}$ $V_{CE} = 10 \text{ V}$ $I_C = 500 \text{ mA}$ $V_{CE} = 10 \text{ V}$	[75] [100] [100] [50]	-	300	

1. Pulsed duration = 300  $\mu\text{s}$ , duty cycle  $\leq 2\%$

2. The post-irradiation gain calculation of  $[h_{FE}]$ , made using  $h_{FE}$  measurements from prior to and on completion of irradiation testing and after each annealing step if any, shall be as specified in MILSTD-750 method 1019.

Table 9. 2N2907ASW35 post radiation electrical characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CEO}$	Collector-Emitter Breakdown voltage	$I_C = 10 \text{ mA}$	60	-	-	V
$V_{(BR)CBO}$	Collector-Base Breakdown voltage	$I_E = 10 \mu\text{A}$	60	-	-	V
$V_{(BR)EBO}$	Emitter-Base Breakdown voltage	$I_E = 10 \mu\text{A}$	5	-	-	V
$I_{CEX}$	Collector-Emitter Cut-off current	$V_{CE} = 30 \text{ V}, V_{EB} = 500 \text{ mV}$	-	-	50	nA
$I_{CBO}$	Collector-Base Cut-off current	$V_{CB} = 50 \text{ V}$	-	-	10	nA
$h_{FE1}^{(1)}$	Forward-Current Transfer Ratio	$V_{CE} = 10 \text{ V}, I_C = 0.1 \text{ mA}$	50	-	-	-
$h_{FE1}^{(2)}$		$V_{CE} = 10 \text{ V}, I_C = 0.1 \text{ mA}$	42	-	-	-
$h_{FE2}$		$V_{CE} = 10 \text{ V}, I_C = 10 \text{ mA}$	100	-	-	-
$h_{FE3}$		$V_{CE} = 10 \text{ V}, I_C = 150 \text{ mA}$	100	-	300	-
$h_{FE4}$		$V_{CE} = 10 \text{ V}, I_C = 500 \text{ mA}$	50	-	-	-
$V_{CE(sat)}$	Collector-Emitter Saturation voltage	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$	-	-	400	mV
$V_{BE(sat)}$	Base-Emitter Saturation voltage	$I_C = 150 \text{ mA}, I_B = 15 \text{ mA}$	-	-	1.3	V

1. @ 50 krad (Si)

2. @ 70 krad (Si)

## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

**Table 10. Product mass summary**

<b>Package</b>	<b>Mass (g)</b>
UB	0.06
LCC-3	0.06
TO-18	0.40

Table 11. UB mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	1.16		1.42
C	0.46	0.51	0.56
D	0.56	0.76	0.96
E	0.92	1.02	1.12
F	1.95	2.03	2.11
G	2.92	3.05	3.18
I	2.41	2.54	2.67
J	0.42	0.57	0.72
K	1.37	1.52	1.67
L	0.41	0.51	0.61
M	2.46	2.54	2.62
N	1.81	1.91	2.01
r		0.20	
r1		0.30	
r2		0.56	

Figure 9. UB drawings

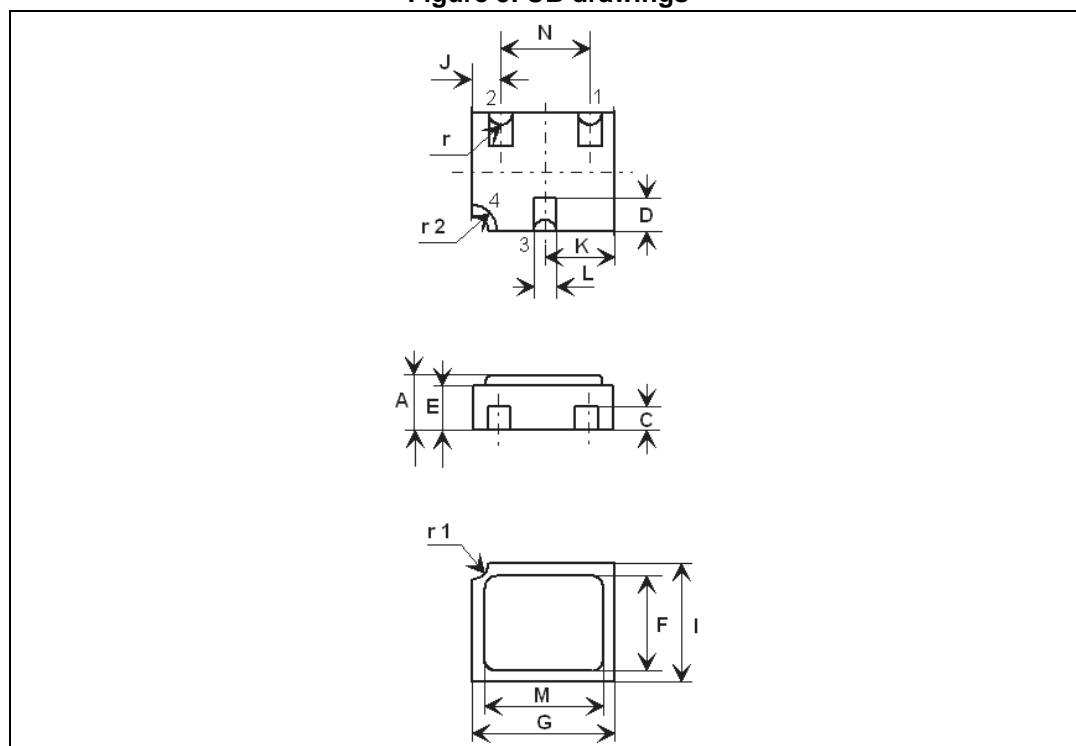


Table 12. LCC-3 mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	1.16		1.42
C	0.45	0.50	0.56
D	0.60	0.76	0.91
E	0.91	1.01	1.12
F	1.95	2.03	2.11
G	2.92	3.05	3.17
I	2.41	2.54	2.66
J	0.42	0.57	0.72
K	1.37	1.52	1.67
L	0.40	0.50	0.60
M	2.46	2.54	2.62
N	1.80	1.90	2.00
R		0.30	

Figure 10. LCC-3 drawings

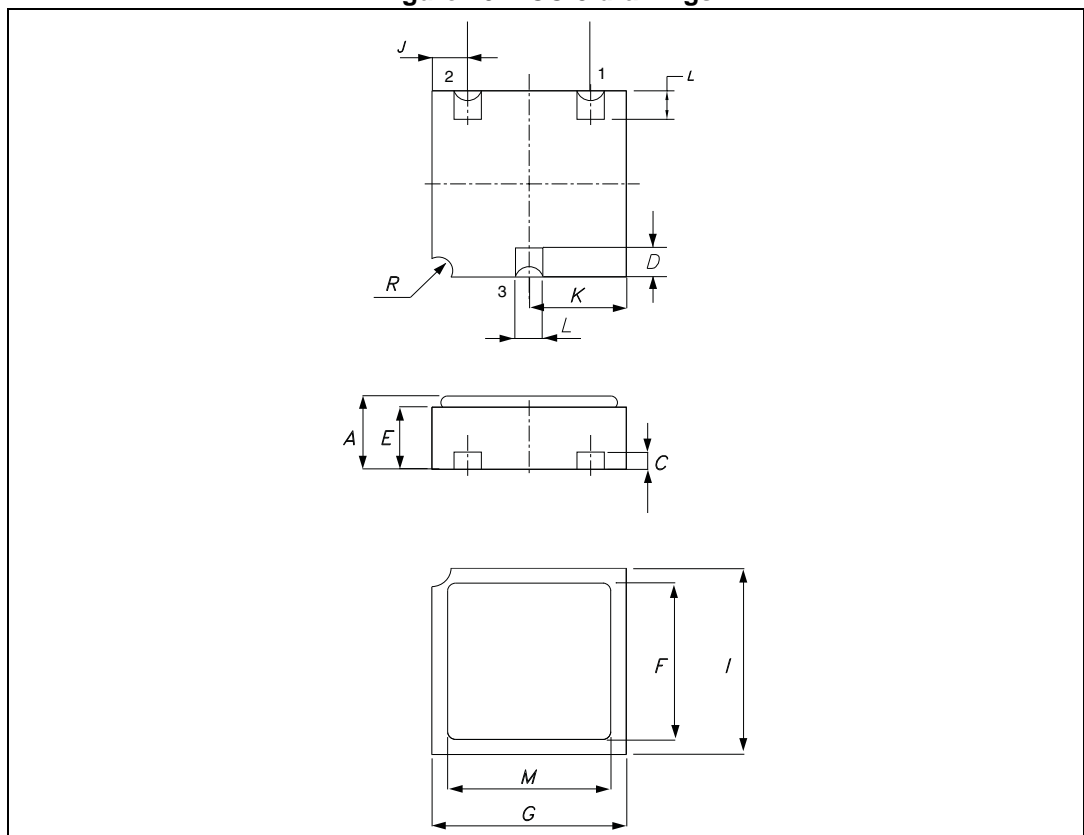
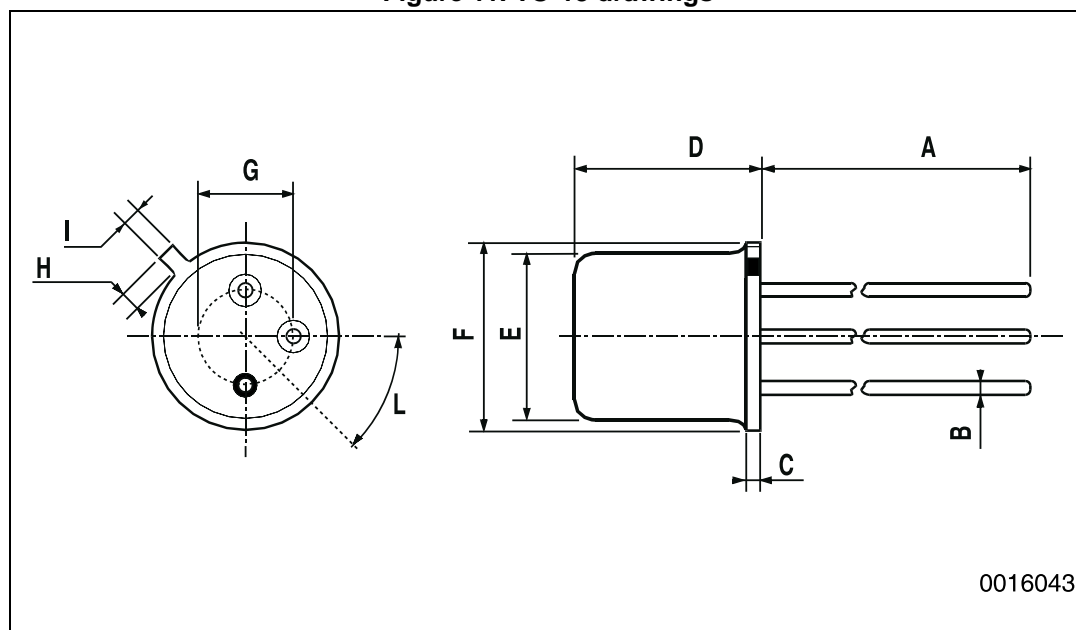


Table 13. TO-18 mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A		12.7	
B			0.49
D			5.3
E			4.9
F			5.8
G	2.54		
H			1.2
I			1.16
L	45°		

Figure 11. TO-18 drawings



Order codes



## 5 Order codes

Table 14. Ordering information

Part number	Agency specification	EPPL	Quality level	Radiation level	Package	Lead finish	Marking <sup>(1)</sup>	Packing
J2N2907AUB1	-	-	Engineering Model JANS	-	UB	Gold	J2907AUB1	WafflePack
2N2907AUB1	-	-	Engineering Model ESCC	-	UB	Gold	2N2907AUB1	WafflePack
SOC2907A	-	-	Engineering Model ESCC	-	LCC-3	Gold	SOC2907A	WafflePack
JANS2N2907AUBG	MIL-PRF-19500/291	-	JANS	-	UB	Gold	JS2907	WafflePack
JANS2N2907AUBT	MIL-PRF-19500/291	-	JANS	-	UB	Solder Dip	JS2907	WafflePack
2N2907ARUBG	5202/001/06R	Target	ESCC	100 krad ESCC	UB	Gold	520200106R	WafflePack
2N2907ARUBT	5202/001/07R	Target	ESCC	100 krad ESCC	UB	Solder Dip	520200107R	WafflePack
2N2907AUB06SW35 <sup>(2)</sup>	5202/001/06	-	ESCC	100 krad SW	UB	Gold	520200106	WafflePack
2N2907AUB07SW35 <sup>(2)</sup>	5202/001/07	-	ESCC	100 krad SW	UB	Solder Dip	520200107	WafflePack
2N2907AUB06	5202/001/06	Target	ESCC	-	UB	Gold	520200106	WafflePack
2N2907AUB07	5202/001/07	Target	ESCC	-	UB	Solder Dip	520200107	WafflePack
SOC2907ARHRG	5202/001/04R	Yes	ESCC	100 krad ESCC	LCC-3	Gold	520200104R	WafflePack
SOC2907ARHRT	5202/001/05R	Yes	ESCC	100 krad ESCC	LCC-3	Solder Dip	520200105R	WafflePack
SOC2907ASW35 <sup>(2)</sup>	5202/001/04 or 05 <sup>(3)</sup>	-	ESCC	100 krad SW	LCC-3	Gold or Solder Dip	520200104 or 05 <sup>(3)</sup>	WafflePack
SOC2907AHRB	5202/001/04 or 05 <sup>(3)</sup>	Yes	ESCC	-	LCC-3	Gold or Solder Dip	520200104 or 05 <sup>(3)</sup>	WafflePack
2N2907ARHRG	5202/001/01R	-	ESCC	100 krad ESCC	TO-18	Gold	520200101R	Strip Pack
2N2907ARHRT	5202/001/02R	-	ESCC	100 krad ESCC	TO-18	Solder Dip	520200102R	Strip Pack





**Table 14. Ordering information (continued)**

Part number	Agency specification	EPPL	Quality level	Radiation level	Package	Lead finish	Marking <sup>(1)</sup>	Packing
2N2907ASW35 <sup>(2)</sup>	5202/001/01 or 02 <sup>(3)</sup>	-	ESCC	100 krad SW	TO-18	Gold or Solder Dip	520200101 or 02 <sup>(3)</sup>	Strip Pack
2N2907AHR	5202/001/01 or 02 <sup>(3)</sup>	-	ESCC	-	TO-18	Gold or Solder Dip	520200101 or 02 <sup>(3)</sup>	Strip Pack

1. Specific marking only. The full marking includes in addition: For the engineering models : ST logo, date code, country of origin (FR). For ESCC flight parts : ST logo, date code, country of origin (FR), ESA logo, serial number of the part within the assembly lot. For JANS flight parts : ST logo, date code, country of origin (FR), manufacturer code (CSTM), serial number of the part within the assembly lot.
2. Not recommended for new design.
3. Depending ESCC part number mentioned on the purchase order.

Contact ST sales office for information about the specific conditions for:

- Products in die form
- Other JANS quality levels
- Tape and reel packing

## 6 Shipping details

### 6.1 Date code

Date code xyywwz is structured as below table:

**Table 15. Date code**

	x	yy	ww	z
EM (ESCC & JANS)	3	last two digits of the year	week digits	lot index in the week
ESCC FLIGHT	-			
JANS FLIGHT (diffused in Singapore)	W			

### 6.2 Documentation

**Table 16. Documentation provided for each type of product**

Quality level	Radiation level	Documentation
Engineering model	-	-
JANS Flight	-	Certificate of conformance
JANS Flight	100 krad	Certificate of conformance 50 rad/s radiation verification test report
ESCC Flight	-	Certificate of conformance
ESCC Flight	100 krad	Certificate of conformance 0.1 rad/s radiation verification test report

## 7 Revision history

**Table 17. Document revision history**

Date	Revision	Changes
09-Feb-2009	1	Initial release
05-Jan-2010	2	Modified <a href="#">Table 1 on page 1</a>
30-Nov-2011	3	Minor text changes in the document title and description on the coverpage
14-May-2012	4	New package inserted (UB). Updated: – <a href="#">Table 1: Device summary</a> , <a href="#">Table 2: Absolute maximum ratings</a> and <a href="#">Table 3: Thermal data</a> . – <a href="#">Section 2: Electrical characteristics</a> and <a href="#">Section 4: Package mechanical data</a> . Added: – <a href="#">Section : Order codes</a> and <a href="#">Section 6: Shipping details</a> .
03-Jun-2013	5	Added: – new section <a href="#">Radiation hardness assurance</a> – <a href="#">Table 9 on page 12</a> – Corrected the revision number and dates of revision 3
18-Sep-2013	6	Updated <a href="#">Table 1: Device summary</a> and <a href="#">Section 5: Order codes</a>

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